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U.S. PATENT DOCUMENTS Classification Name Document Number Country Code-Number-Kind Code Date 264 438 MM-YYYY 257 Su et al. 438 10-2000 US-6,133,096 Cho et al. 02-2000 US-6,027,971 В US-US-D US-Ε US-F US-G US-Н US-US-US-US-L FOREIGN PATENT DOCUMENTS US-Classification M Name Date Country **Document Number** MM-YYYY Country Code-Number-Kind Code Ν 0 Р Q R s NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) T U W

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